

Notice of References Cited

Application/Control No.

10/574,583

Applicant(s)/Patent Under
Reexamination
MATSUMOTO ET AL.

Examiner

JAIME M. GREENE

Art Unit

1634

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0127904	06-2006	Segawa et al.	435/006
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lee, et al. IEEE-NANO 2003, Third IEEE Conference on Nanotechnology, 12-14 Aug. 2003; .2: 729-732.
	V	Chou, et al. Biophys J. 2002 October; 83(4): 2170-2179.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.